

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/658,173	CHEN ET AL.	
Examiner		Art Unit		Page 1 of 1
Hung T Vy		2821		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0117325 A1	06-2003	Jo et al.	343/702
	B	US-6,606,062 B2	08-2003	Ngounou Kouam et al.	343/700MS
	C	US-6,720,924 B2	04-2004	Tomomatsu et al.	343/700MS
	D	US-6,693,593 B1	02-2004	Burgess, Paul	343/700MS
	E	US-6,738,023 B2	05-2004	Scott et al.	343/700MS
	F	US-6,408,190 B1	06-2002	Ying, Zhenong	455/553.1
	G	US-6,343,208 B1	01-2002	Ying, Zhenong	455/575.7
	H	US-6,747,600 B2	06-2004	Wong et al.	343/700MS
	I	US-6,707,431 B2	03-2004	Byun et al.	343/702
	J	US-6,133,879 A	10-2000	Grangeat et al.	343/700MS
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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